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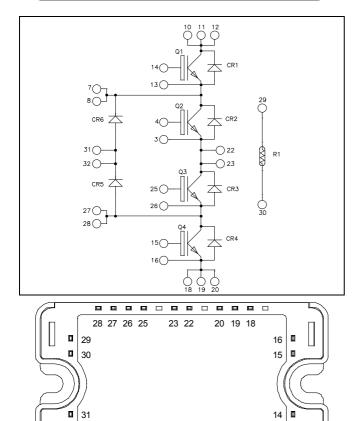
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Three level inverter Trench + Field Stop IGBT **Power Module**



All multiple inputs and outputs must be shorted together Example: 10/11/12 ; 7/8 ...

7 8

O1 to O4 Absolute maximum ratings

32

> 2 3 4

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APTGT30TL60T3G

$V_{CES} = 600V$ $I_{\rm C} = 30 {\rm A}$ (*a*) ${\rm Tc} = 80^{\circ}{\rm C}$

Application

- Solar converter
- Uninterruptible Power Supplies

Features .

- Trench + Field Stop IGBT Technology
 - Low voltage drop _
 - Low tail current
 - Switching frequency up to 20 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Stable temperature behavior •
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile •
- **RoHS** Compliant

Symbol	Parameter		Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage		600	V
Т	Continuous Collector Current	$T_C = 25^{\circ}C$	50	
I _C	Continuous Conector Current	$T_C = 80^{\circ}C$	30	А
I _{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	60	
V _{GE}	Gate – Emitter Voltage		±20	V
P _D	Maximum Power Dissipation	$T_C = 25^{\circ}C$	90	W
RBSOA	Reverse Bias Safe Operating Area	$T_{\rm J} = 150^{\circ}{\rm C}$	60A @ 550V	

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10 11 12

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Q1 to Q4 Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μA
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
V _{CE(sat)}	Conector Ennitier Saturation Voltage	$I_C = 30A$	$T_{j} = 150^{\circ}C$		1.7		v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 400 \mu A$		5.0	5.8	6.5	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	= 0V			300	nA

Q1 to Q4 Dynamic Characteristics

-	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			1600		
C _{oes}	Output Capacitance	$V_{CE} = 25V$			110		pF
C _{res}	Reverse Transfer Capacitance	f = 1 MHz			50		
Q _G	Gate charge	$V_{GE} = \pm 15V, I_C = 3$ $V_{CE} = 300V$	30A		0.3		μC
T _{d(on)}	Turn-on Delay Time	Inductive Switch	hing (25°C)		110		
T _r	Rise Time	$V_{GE} = \pm 15V$			45		19.0
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 30A$ $R_{G} = 10\Omega$			200		ns
T _f	Fall Time				40		
T _{d(on)}	Turn-on Delay Time	Inductive Switch	hing (150°C)		120		
T _r	Rise Time	$V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 30A$			50		ns
T _{d(off)}	Turn-off Delay Time				250		
T _f	Fall Time	$R_G = 10\Omega$			60		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15 V$	$T_j = 25^{\circ}C$		0.16		mJ
Lon	Turi-on Switching Energy	$V_{Bus} = 300V$	$T_{j} = 150^{\circ}C$		0.3		1115
E _{off}	Turn-off Switching Energy	$I_C = 30A$	$T_j = 25^{\circ}C$		0.7		mJ
2011		$R_G = 10\Omega$	$T_{j} = 150^{\circ}C$		1.05		1110
I _{sc}	Short Circuit data	$V_{GE} \le 15V$; $V_{Bus} = 360V$ $t_p \le 6\mu s$; $T_1 = 150^{\circ}C$			150		А
R _{thJC}	Junction to Case Thermal Resistance					1.6	°C/W



CR1 to CR4 diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Test Conditions		Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I _{RM}	Maximum Reverse Leakage Current	V _R =600V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 350	μA
I _F	DC Forward Current		$Tc = 80^{\circ}C$		20		Α
V _F	Diode Forward Voltage	$I_F = 20A$	$T_i = 25^{\circ}C$		1.6	2	V
v _F	Didde Forward Voltage	$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.5		v
+	Deserve Deserver Time	$T_j =$	$T_j = 25^{\circ}C$		100		19.0
t _{rr}	Reverse Recovery Time		$T_{i} = 150^{\circ}C$		150		ns
0	Deserve Deservers Change	$I_F = 20A$	$T_j = 25^{\circ}C$		1.1		чС
Qrr	Q_{rr} Reverse Recovery Charge $V_R = 300V$ di/dt =1600A/µs	$T_{i} = 150^{\circ}C$		2.3		μC	
Г			$T_i = 25^{\circ}C$		0.23		
E _{rr}	Reverse Recovery Energy		$T_1 = 150^{\circ}C$		0.50		mJ
R _{thJC}	Junction to Case Thermal Resistance					3.25	°C/W

CR5 & CR6 diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V	
I _{RM}	Maximum Reverse Leakage Current	V _R =600V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 350	μΑ	
I _F	DC Forward Current		$Tc = 80^{\circ}C$		30		Α	
V _F	Diada Farward Valtaga	$I_F = 30A$	$T_i = 25^{\circ}C$		1.6	2	V	
v _F	Diode Forward Voltage	$V_{GE} = 0V$	$T_{j} = 150^{\circ}C$		1.5		v	
t _{rr}	Reverse Recovery Time		$T_j = 25^{\circ}C$		100		ns	
ι _{rr}	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		150		115	
Q _{rr}	Reverse Recovery Charge	$I_{\rm F} = 30 \text{A}$ $V_{\rm R} = 300 \text{V}$	$T_j = 25^{\circ}C$		1.5		μC	
Qrr	$v_R = 300v$ di/dt =1800A/µs	$T_{i} = 150^{\circ}C$		3.1		μΟ		
Б	D D		$T_j = 25^{\circ}C$		0.34		mI	
E _{rr}	Reverse Recovery Energy			Тј	$T_{j} = 150^{\circ}C$		0.75	
R _{thJC}	Junction to Case Thermal Resistance					2.45	°C/W	

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		Κ
$\Delta B/B$		T _C =100°C		4		%
	<i>B</i> The transmission of transmission of the transmission of transmission of the transmission of transmission o					

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature

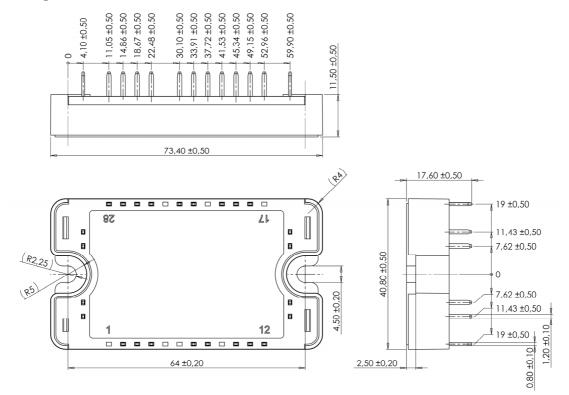
R_T: Thermistor value at T



Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T _J	Operating junction temperature range			-40		175	
T _{STG}	Storage Temperature Range			-40		125	°C
T _C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					110	g

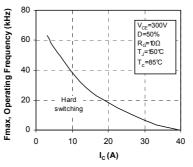
SP3 Package outline (dimensions in mm)



See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

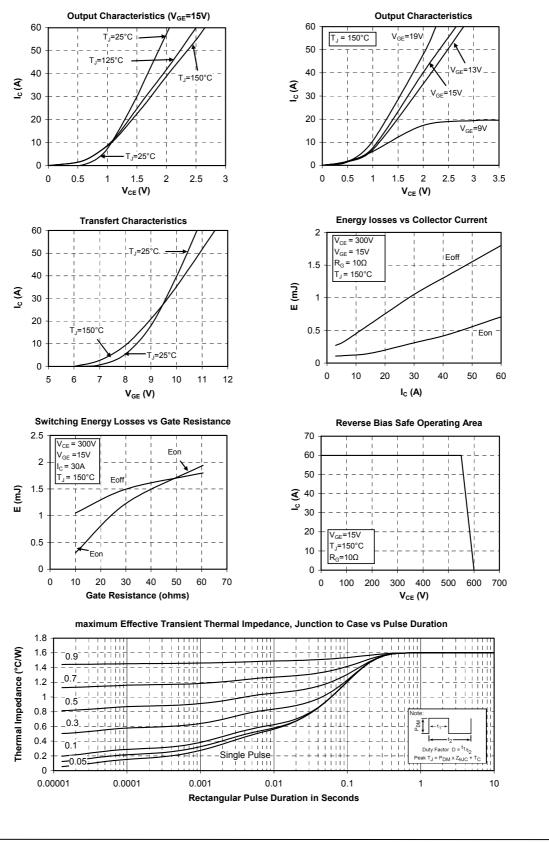
Q1 to Q4 Typical performance curve

Operating Frequency vs Collector Current



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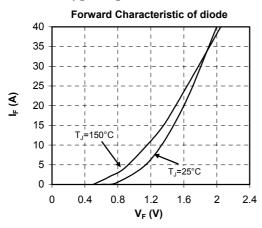


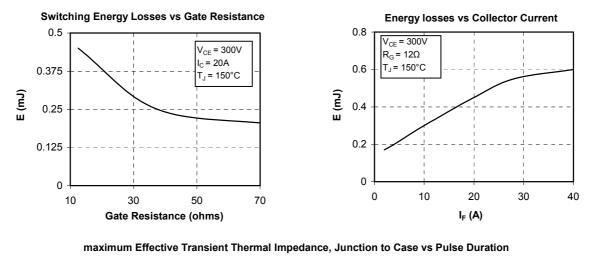


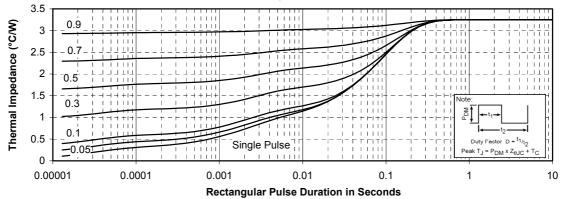
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CR1 to CR4 Typical performance curve

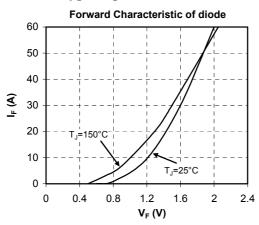


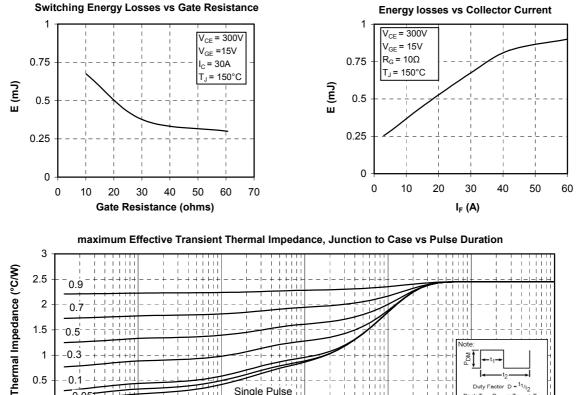


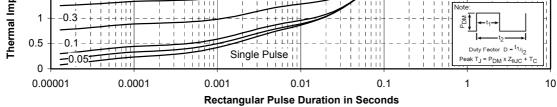




CR5 & CR6 Typical performance curve









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